

Multi-Channel

Silicon ESD Protector
Overvoltage Protection Device

PRODUCT: SESD1004Q4UG-0020-090

DOCUMENT: SCD28190 REV LETTER: C REV DATE: March 2, 201

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Specification Status: RELEASED

BENEFITS

- Industry-leading lowest capacitance; provides lowest insertion loss for high speed data signals
- Industry's smallest footprint and lowest profile multi-channel ESD array helps to optimize board space
- Flow-through and single connection design helps routing PCB matched impedance high speed data lines
- Helps protect electronic circuits against damage from Electrostatic Discharge (ESD), surge and cable discharge events
- Assists equipment to pass IEC61000-4-2, level 4 testing

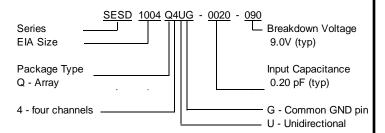
FEATURES

- Low capacitance: 0.20 pF (200fF) (typ)
- Low leakage current: 25nA @ 5V (typ)
- Low clamping voltage: +9.20 / -0.8V (typ)
 @ (tp=8x20µs, lpp=2A)
- ESD maximum rating per IEC61000-4-2 standard:
 - 20kV contact discharge
 - o 20kV air discharge
- Surge: 2A (max) @ (tp=8x20µs) per IEC61000-4-5
- Small size and low profile: XDFN array packages 0.31mm height

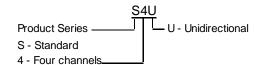
APPLICATIONS

- Consumer, mobile and portable electronics
- Tablet PC and external storage with high speed interfaces
- Ultra-high speed data lines
- USB 3.0/2.0, HDMI 1.3/1.4, DisplayPort, Thunderbolt (Light Peak), V-by-One HS, and LVDS interfaces
- Applications requiring high ESD performance in small DFN packages

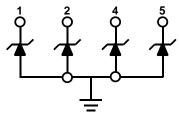
PART NUMBERING



PART MARKING

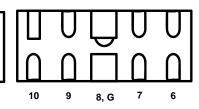


SCHEMATIC AND PIN CONFIGURATION



G, 3, 8

。—S4U



3, G

MATERIALS INFORMATION

RoHS Compliant

ELV Compliant

Halogen Free *

Lead Free









* Habgen Free refers to: Dr≤900ppm, Q≤900ppm, Dr+Q≤1500ppm SESD devices med: MSL-1 Requirements DFN case epoxy meets UL 94 V-0

Top View

Bottom View



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DEVICE MAXIMUM RATING

ESD Withstand ⁽¹⁾ (IEC 61000-4-2, level 4)		Temperature		Peak Current (tp=8x20μs)
Contact (kV)	Air (kV)	Operating (°C)	Storage (°C)	lpp (A)
20	20	-55 to +125	-55 to +150	2.0

^{(1) 20}kV @ 1 pulse; 10kV @ 100 pulses; 8kV @ 1,000 pulses (under IEC6100-4-2)

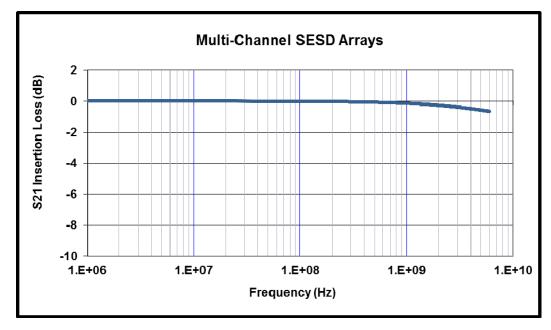
- Device maximum rating @ T = 25°C, unless otherwise specified
- Caution: Stress exceeding Device Maximum Ratings may damage the device Prolonged exposure to stresses above the Recommended Operating Conditions may affect device reliability

DEVICE ELECTRICAL CHARACTERISTICS

Input Capacitance		Breakdown Voltage	Reverse Working		Reverse Leakage Current		Clamping Voltage
@ $V_R = 0V$, $f = 3GHz$, I/O to GND (pF)		V _{BR} @ I _T =1mA (V)	Voltage (V)		I _L @ V _{RWM} =5.0V (nA)		V _{CL} @ Ipp=2.0A (V)
Тур	Maximum	Тур	Min	Max	Тур	Max	Тур
0.20	0.22	+9.00 / -0.80	0	+8.00	25.0	50.0	+9.20 / -0.80

• All device electrical characteristics @ T = 25°C, unless otherwise specified

FIGURE 1. INSERTION LOSS DIAGRAM



Application	Bit Rate (Gbps)	@Freq (GHz)	Ins. Loss (dB)
HDMI 1.4 (1080P)	2.25	1.13	-0.15
DisplayPort	2.70	1.35	-0.20
HDMI 1.4 (4K / QuadHD)*	3.40	1.70	-0.23
USB3.0	5.00	2.50	-0.29
eSATA	6.00	3.00	-0.35
Thunderbolt	10.0	5.00	-0.50

^{*}HDMI 4K / QuadHD resolutions (4096 x 2160) ready



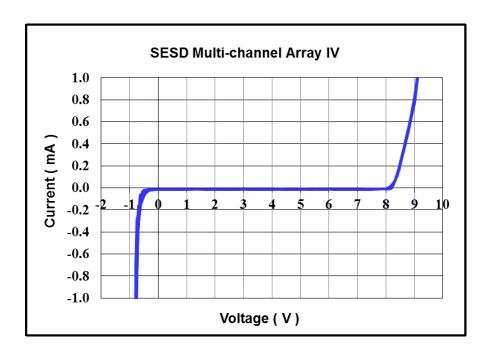
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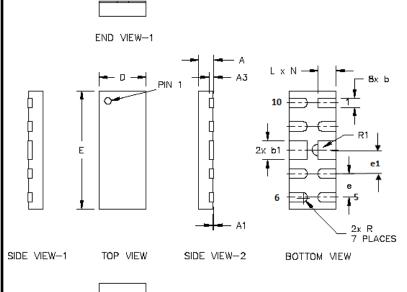
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FIGURE 2. DEVICE IV CURVE



DEVICE DIMENSIONS

END VIEW-2



	SESD1004Q4UG-0020-090					
	Millimeters			Inches		
Dim	Min	Nom	Max	Min	Nom	Max
Α	0.30	0.31	0.32	0.012	0.012	0.013
A 1	0.00		0.05	0		0.002
A3		0.10 ref.	ı	(0.004 ret	
D	0.90	1.00	1.10	0.035	0.039	0.043
E	2.40	2.50	2.60	0.094	0.098	0.102
b	0.15	0.20	0.25	0.006	0.008	0.010
b1	0.35	0.40	0.45	0.014	0.016	0.018
L	0.30	0.38	0.43	0.012	0.015	0.017
е	C).50 BS(C	0	.020 BS	С
e1	0.50 BSC			0	.020 BS	С
N	10				10	
R	0.08 BSC			0.003 BSC		
R1	().13 BS(2	0	.005 BS	С

BSC - Basic Spacing between Centers



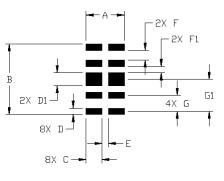
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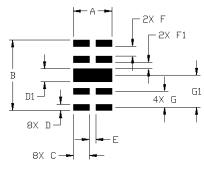
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RECOMMENDED LANDING PATTERN:







Alternate

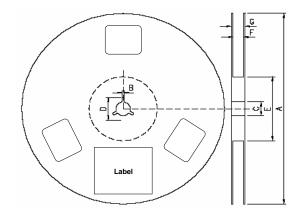
SESD Landing Pad Layout 10 Pin 4-ch Standard FT Array						
Symbol	1 1					
Α	1.20	0.047				
В	2.20	0.087				
С	0.50	0.020				
D	0.20	0.008				
D1	0.40	0.016				
E	0.20	800.0				
F	0.30	0.012				
F1	0.20	0.008				
G	0.50 BSC	0.020 BSC				
G1	1.00 BSC	0.039 BSC				

BSC - Basic Spacing between Centers

PACKAGING

Packaging	Tape & Reel	Standard Box
SESD1004Q4UG-0020-090	5,000	25,000

REEL DIMENSIONS



Dimensions	Α	В	С	D	E	F	G
(mm)	180.0 ± 1.5	2.3. 0 ± 0.2	13.0 + 0.5 / -0.2	17.3 ± 0.2	60.5 ± 1.5	8.4 +1.5/-0.0	14.4 (max)

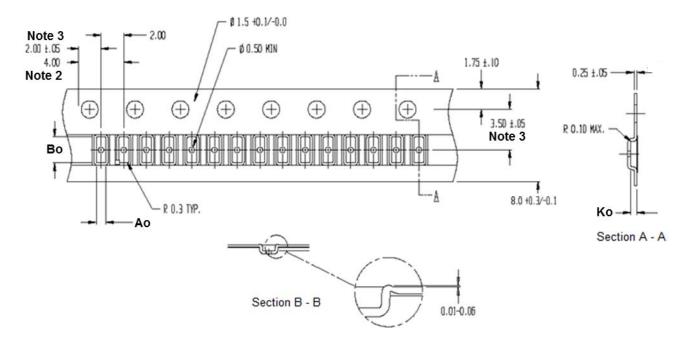


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CARRIER TAPE DIMENSIONS



Ao	1.20 ± 0.05
Во	2.70 ± 0.05
Ko	0.51 ± 0.05

Note 1. All dimensions in mm

Note 2. 10 sprocket hole pitch cumulative tolerance \pm 0.2

Note 3. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole

Note 4. Ao and Bo are calculated on a plane at a distance "R" at the bottom of the pocket

Note 5. Tolerances unless noted 1PL ± 0.20, 2PL ± 0.10



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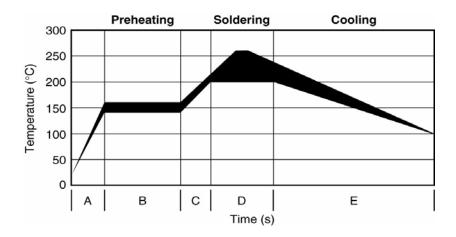
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SOLDER REFLOW RECOMMENDATION

Α	Temperature	From ambient to	30s to 60s	
_	ramp up 1	Preheating temperature		
В	Preheating	140°C - 160°C	60s to 120s	
С	Temperature	From Preheating to Main	20s to 40s	
ramp up 2		heating temperature	205 10 405	
		at 200°C	60s ~ 70s	
D	Main heating	at 220°C	50s ~ 60s	
	Main nealing	at 240°C	30s ~ 40s	
		at 260°C	5s ~ 10s	
F	Cooling	From main heating	1°C/c (max)	
	Cooling	temperature to 100°C	4°C/s (max)	

FIGURE 3. REFLOW PROFILE



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